

## Features

- Uses PingWei advanced PerfectMOS2 technology
- Extremely low on-resistance  $R_{DS(on)}$
- Excellent  $Q_g \times R_{DS(on)}$  product(FOM)
- Excellent Low Ciss
- Qualified according to AEC-Q101 criteria

## Beneficts

- High robustness and reliability
- Increases maximum current capability
- Low power loss, high power density
- Easy paralleling

## Applications

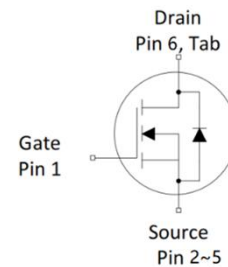
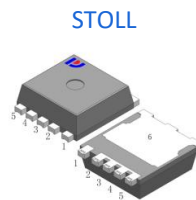
- General Automotive Applications
- Synchronous Rectification for AC/DC Quick Charger
- Battery management



**100% DVDS Tested**  
**100% Avalanche Tested**

## Product Summary

$V_{DS}$	40V
$R_{DS(on)@10V\ typ}$	0.7mΩ
$I_D$ (Silicon limit)	327A



## Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
PWC008N04USQ	C008N04USQ	STOLL	Tape&Reel	13 inches	16mm	1800pcs

## Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	40	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 100^\circ\text{C}$ (Silicon limit) $T_a = 25^\circ\text{C}$ (Package limit) $T_a = 25^\circ\text{C}$ (Note1)	$I_D$	327 231 250 42	A
Pulsed drain current ( $T_C = 25^\circ\text{C}$ , $tp = 100\mu\text{s}$ )	$I_{D\ pulse}$	1534	A
Avalanche energy, single pulse ( $L=0.1\text{mH}$ )	$E_{AS}$	423	mJ
Gate-Source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C = 25^\circ\text{C}$ $T_a = 25^\circ\text{C}$ (see Note1)	$P_{tot}$	191 3.2	W
Operating junction and storage temperature	$T_j, T_{stg}$	-55...+175	$^\circ\text{C}$
Reflow soldering temperature (10s)	$T_{sold}$	260	$^\circ\text{C}$

## Thermal Resistance

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction – case.	RthJC	-	0.6	0.8	°C/W	-
Thermal resistance, junction - ambient(min. footprint)	RthJA	-	-	47	°C/W	Note1

## Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

## Static Characteristic

Drain-source breakdown voltage	$BV_{DSS}$	40	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate threshold voltage	$V_{GS(th)}$	2.0	-	3.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Zero gate voltage drain current	$I_{DSS}$	-	-	1 100	$\mu A$	$V_{DS}=40V, V_{GS}=0V$ $T_j=25^\circ C$ $T_j=150^\circ C$
Gate-source leakage current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	0.70	0.85	mΩ	$V_{GS}=10V, I_D=90A$
		-	0.70	0.85	mΩ	$V_{GS}=10V, I_D=20A$
Transconductance	$g_{fs}$	-	83	-	S	$V_{DS}=5V, I_D=75A$

## Dynamic Characteristic

Input Capacitance	$C_{iss}$	-	7364	11046	pF	$V_{GS}=0V, V_{DS}=25V,$ $f=100KHz$
Output Capacitance	$C_{oss}$	-	1993	2989		
Reverse Transfer Capacitance	$C_{rss}$	-	68	102		
Gate Total Charge	$Q_G$	-	100	150	nC	$V_{DS}=32V, I_D=180A,$ $V_{GS}=10V$
Gate-Source charge	$Q_{gs}$	-	43	65		
Gate-Drain charge	$Q_{gd}$	-	11	22		
Turn-on delay time	$t_{d(on)}$	-	21	-	ns	$V_{GS}=10V, V_{DD}=20V,$ $R_G=1.6\Omega, I_D=20A$
Rise time	$t_r$	-	34	-		
Turn-off delay time	$t_{d(off)}$	-	87	-		
Fall time	$t_f$	-	36	-		
Gate resistance	$R_G$	-	3	-	Ω	$V_{GS}=0V, V_{DS}=0V,$ $f=1MHz$



## Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	$V_{SD}$	-	-	1.2	V	$V_{GS}=0V, I_{SD}=90A$
		-	-	1.2	V	$V_{GS}=0V, I_{SD}=20A$
Body Diode Continuous Forward Current	$I_S$	-	-	250	A	TC = 25°C
Body Diode Pulsed Current	$I_S$ pulse	-	-	1534	A	TC = 25°C, $t_p = 100\mu s$
Body Diode Reverse Recovery Time	$t_{rr}$	-	147	-	ns	$V_D=35V, I_F=10A,$ $dI/dt=100A/\mu s$
Body Diode Reverse Recovery Charge	$Q_{rr}$	-	340	-	nC	

Note 1: 1 inch<sup>2</sup>, single 2oz copper FR-4 PCB.

## Typical Performance Characteristics

Fig 1: Output Characteristics

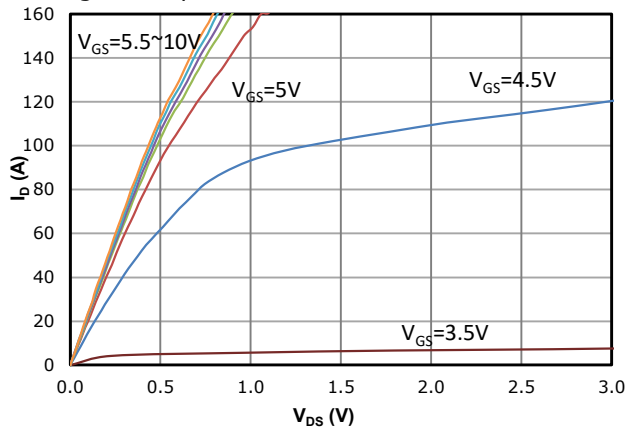


Fig 2: Transfer Characteristics

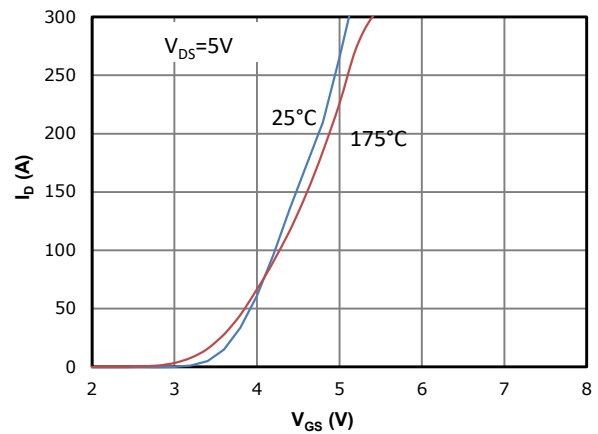


Fig 3: Rds(on) vs Drain Current and Gate Voltage

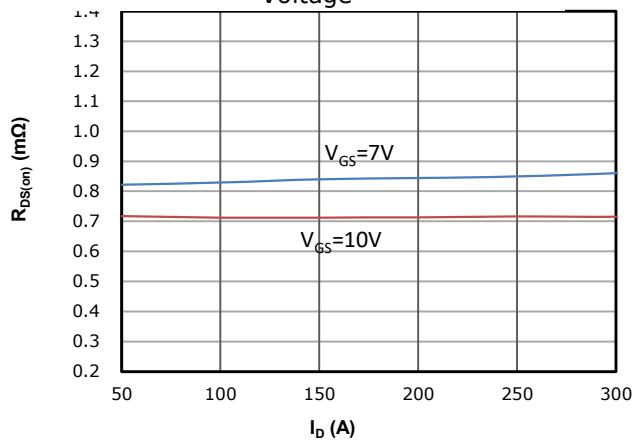


Fig 4: Rds(on) vs Gate Voltage

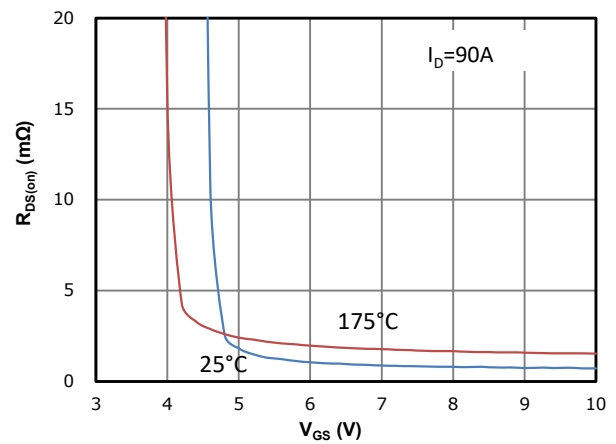


Fig 5: Rds(on) vs. Temperature

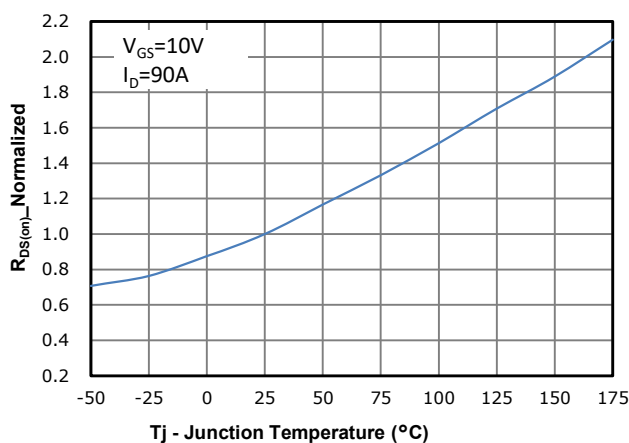


Fig 6: Vgs(th) vs. Temperature

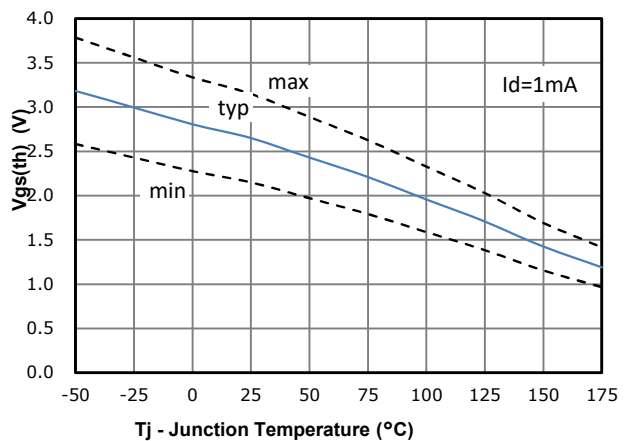


Fig 7: BVdss vs. Temperature

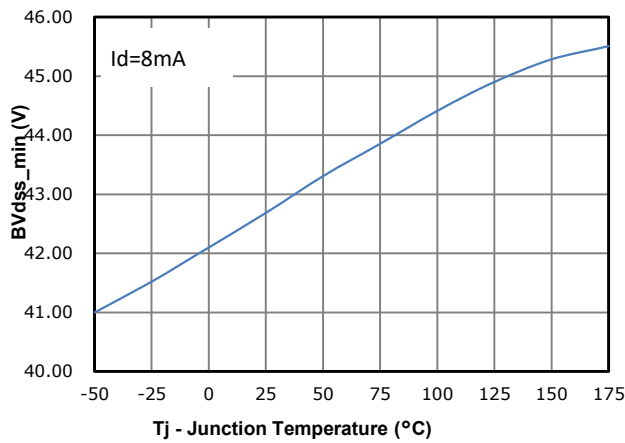


Fig 8: Capacitance Characteristics

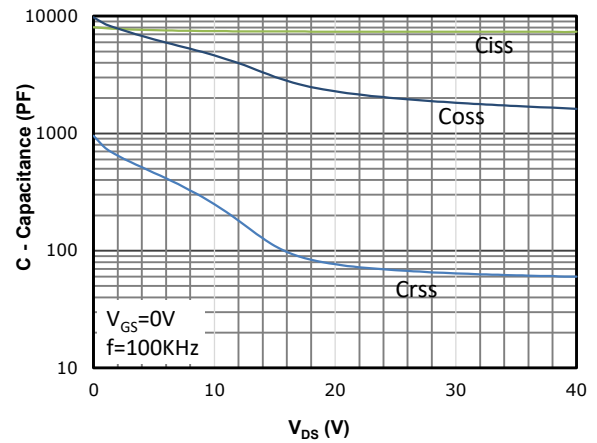


Fig 9: Gate Charge Characteristics

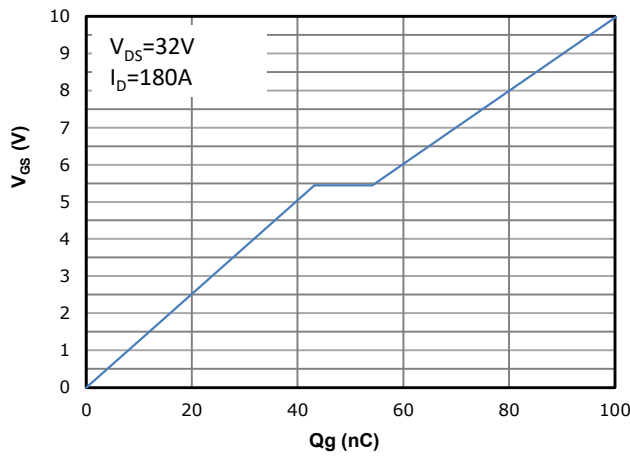


Fig 10: Body-diode Forward Characteristics

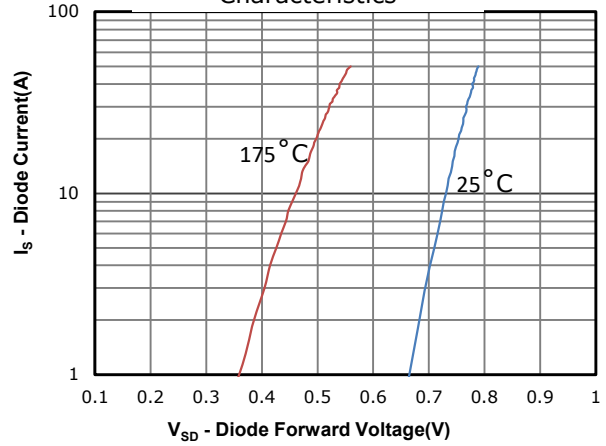


Fig 11: Power Dissipation

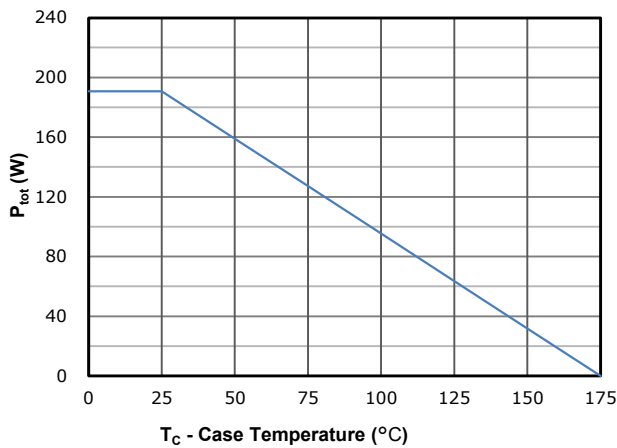


Fig 12: Drain Current Derating

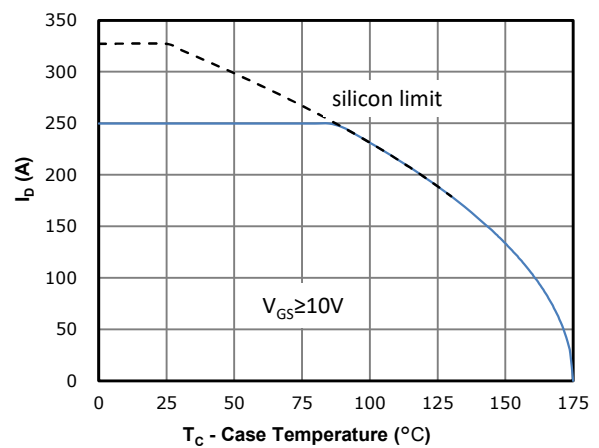


Fig 13: Safe Operating Area

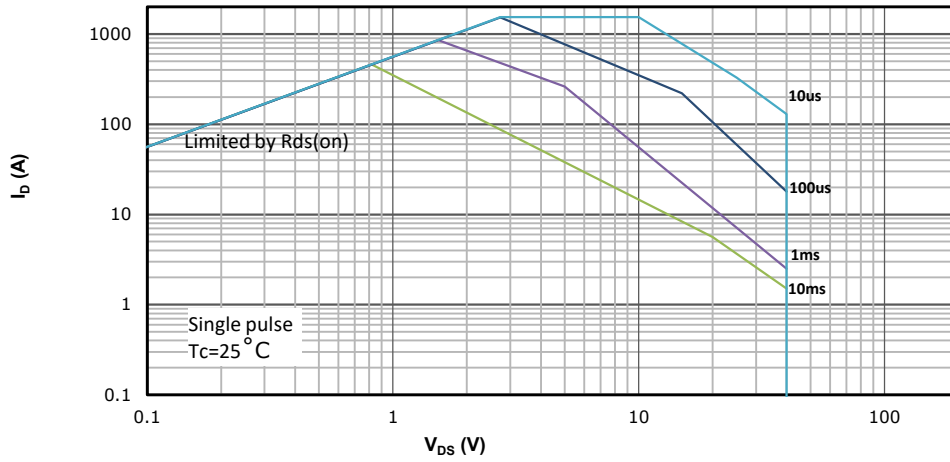


Fig 14: EAS vs. Temperature

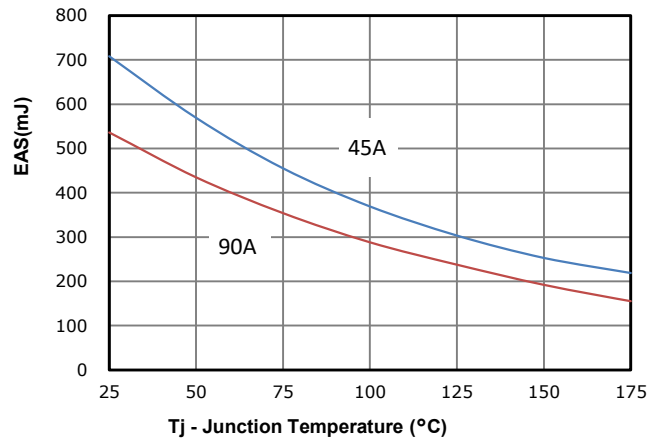
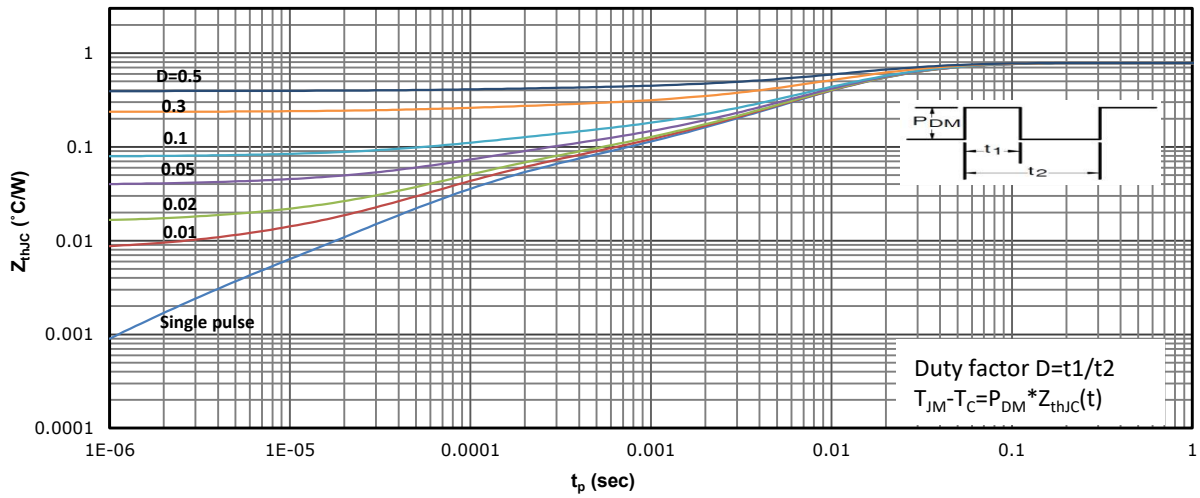
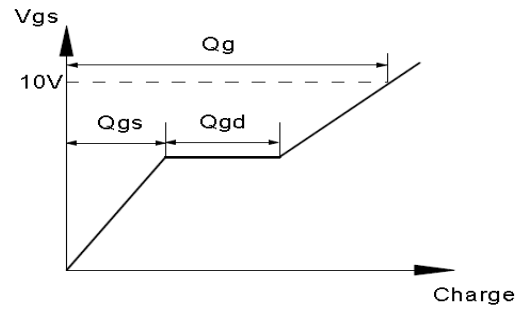
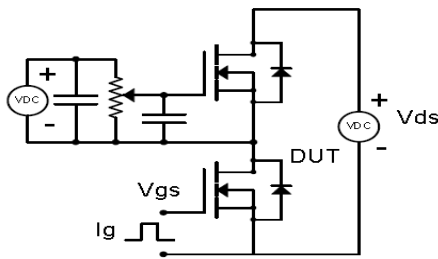


Fig 15: Max. Transient Thermal Impedance

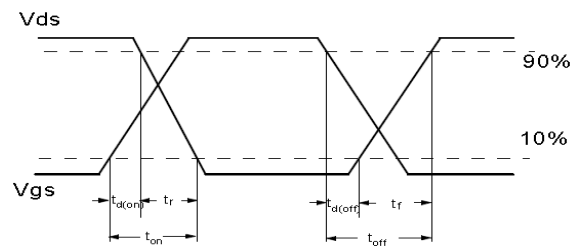
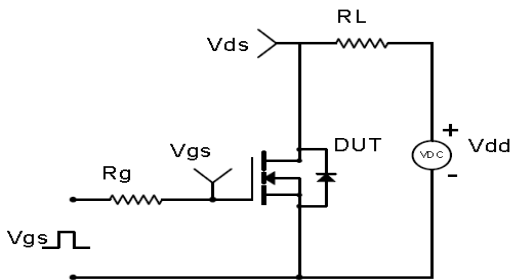


## Test Circuit & Waveform

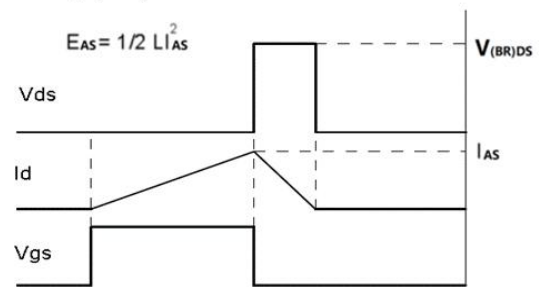
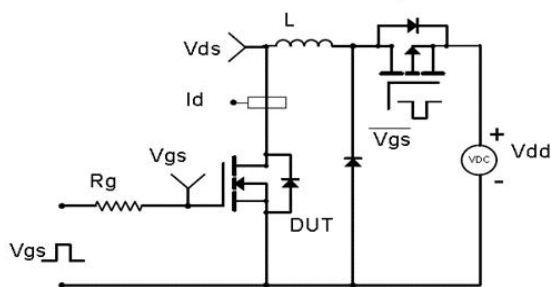
Gate Charge Test Circuit & Waveform



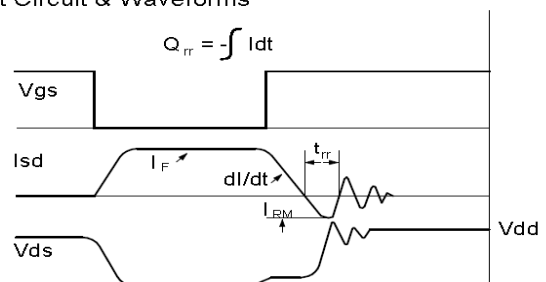
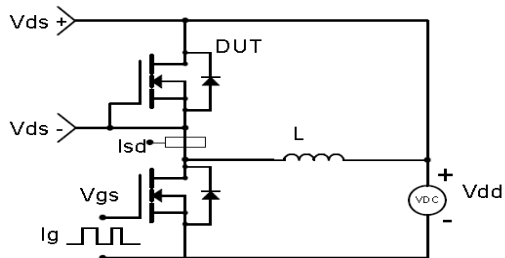
Resistive Switching Test Circuit & Waveforms



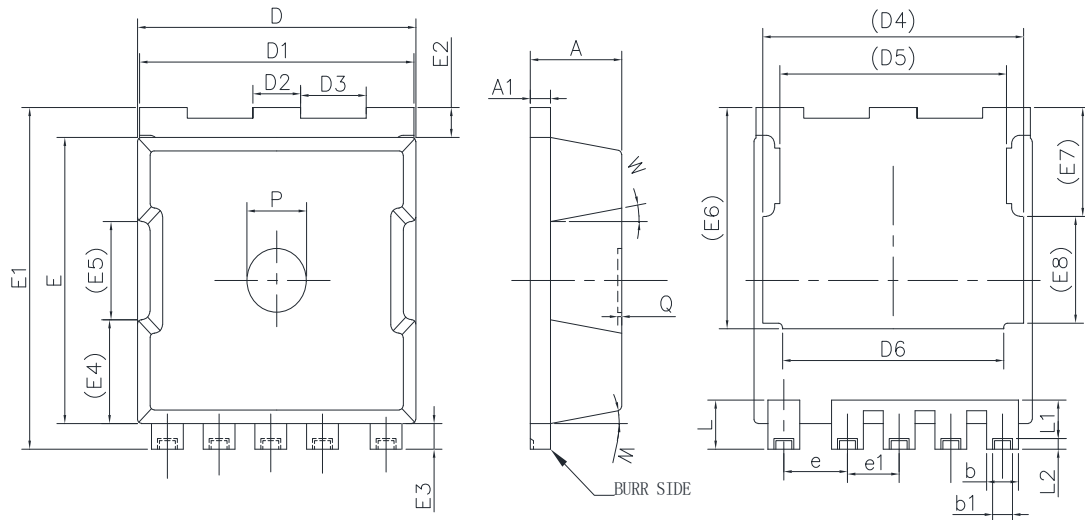
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



## Package Outline: STOLL



SYMBOL	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.20	2.40	0.087	0.094
A1	0.40	0.60	0.016	0.024
b	0.70	0.90	0.028	0.035
b1	0.40	0.60	0.016	0.024
D	6.80	7.20	0.268	0.283
D1	6.80	7.20	0.268	0.283
D2	1.10	1.30	0.043	0.051
D3	1.55	1.75	0.061	0.069
D4	6.56		0.258	
D5	5.70		0.224	
D6	5.56		0.219	
E	6.50	6.90	0.256	0.272
E1	7.80	8.20	0.307	0.323
E2	0.60	0.80	0.024	0.031
E3	0.50	0.70	0.020	0.028
E4	2.43		0.096	
E5	2.30		0.091	
E6	5.18		0.204	
E7	2.55		0.100	
E8	2.50		0.098	
e	1.60		0.063	
e1	1.30		0.051	
L	1.05	1.25	0.041	0.049
L1	0.80	1.00	0.031	0.039
L2	0.15	0.35	0.006	0.014
P	1.40	1.60	0.055	0.063
Q	0.00	0.10	0.000	0.004
W	8°	11°	8°	11°





**Revision History**

Revision	Date	Major changes
1.0	2023/5/19	Release of Design Version.
2.0	2025/2/18	Rth Curve,Id,SOA update.
2.1	2025/8/11	Update pakage ID limit,ID(pulse);Update Ciss/Coss/Crss f=100KHZ

**Disclaimer**

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

The product is not intended for use in applications that require extraordinary levels of quality and reliability, such as aviation/aerospace and life-support devices or systems.

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